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	Filing Date		2000-01-21
	First Named Inventor	David A. Cathey	
	Art Unit	2879	
	Examiner Name	A. Patel	
Attorney Docket Number		2269-7129.2US(95-0582.02/)	

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/ AP/	1	Bauch et al. Apr. 1989 "Effect of Cs Contamination on the Interface State Density of Mnos Capacitors," Applied Surface Science 39:356-363.	<input type="checkbox"/>
/ AP/	2	Branston et al. Oct. 1991 "Field Emission from Metal-Coated Silicon Tips," IEEE Transaction on Electron Devices, vol. 38, No. 10, pp. 72-80, pp. 2329-2333.	<input type="checkbox"/>
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/ AP/	4	Evtukh et al. Jul. 30, 1995, "Parameters of the Tip Arrays Covered by Low Work Function Layers," Institute of Semiconductor Physics Academy of Sciences, Prospect Nauki 45, Kiev-252028, Ukraine (Aug. 1995).	<input type="checkbox"/>

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/ AP/	5	Evtukh, et al. "Parameters of the Tip Arrays Covered by Low Work Function Layers," J. Vac. Sci Tech. B 14 (3), pp. 2130-2134, (Pub. May-June 1996).	<input type="checkbox"/>
/ AP/	6	Macaulay et al. 24 Aug. 1992 "Cesiated thin-film field-emission microcathode arrays," Appl. Phys. Lett., vol. 61, NO. 8, pp. 997-999.	<input type="checkbox"/>
/ AP/	7	Michaelson H.B Jan. 1978 "Relation Between an Atomic Electronegativity Scale and the Work Function," IBM J. Res. Develop, vol. 22, No. 1, pp. 72-80.	<input type="checkbox"/>

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